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(54) **RECEIVER EQUALIZATION CIRCUITRY USING VARIABLE TERMINATION AND T-COIL**

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CPC ***H04B 3/141*** (2013.01); ***H04B 3/145*** (2013.01); ***H04B 3/26*** (2013.01); ***H04B 3/46*** (2013.01); *H01F 17/08* (2013.01)

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(Continued)

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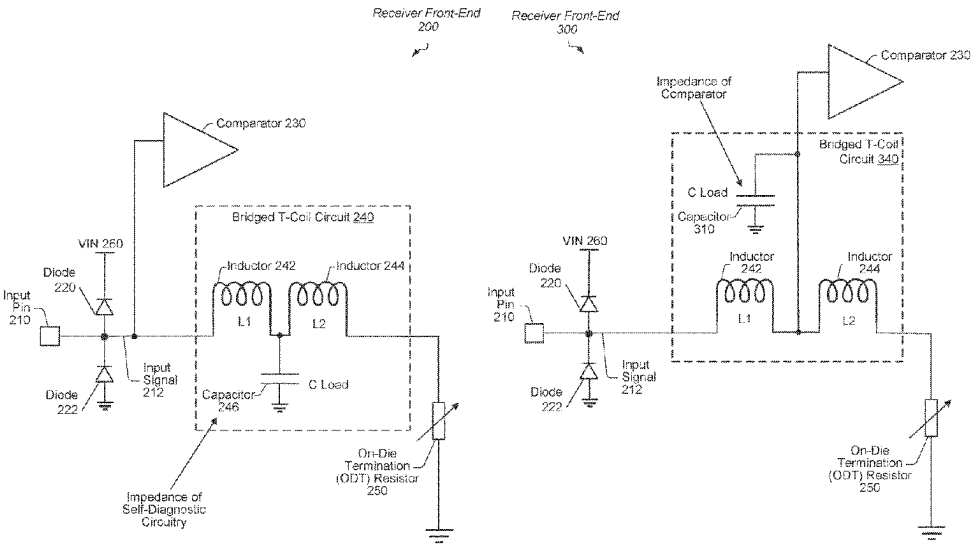
(57) **ABSTRACT**

Systems, apparatuses, and methods for performing efficient data transfer in a computing system are disclosed. A computing system includes multiple transmitters sending singled-ended data signals to multiple receivers. In order to better handle noise issues when using single-ended signaling, one or more of the receivers include equalization circuitry and termination circuitry. The termination circuitry prevents reflection on a corresponding transmission line ending at a corresponding receiver. The equalization circuitry uses a bridged T-coil circuit to provide continuous time linear equalization (CTLE) with no feedback loop. The equalization circuitry performs equalization by providing a high-pass filter that offsets the low-pass characteristics of a corresponding transmission line. A comparator of the receiver receives the input signal and compares it to a reference voltage. The placement of the comparator and the ratio of the inductances of the inductors of the bridged T-coil circuit are based on whether the receiver includes self-diagnostic circuitry.

20 Claims, 8 Drawing Sheets



(51) **Int. Cl.**
H04B 3/46 (2015.01)
H01F 17/08 (2006.01)

(58) **Field of Classification Search**
CPC ... H03H 7/40; H03H 7/46; H04B 1/00; H04B 1/04; H04B 1/10; H04B 1/16; H04B 3/00; H04B 3/26; H04B 3/46; H04B 3/141; H04B 3/145
USPC 375/219, 229, 252, 295, 316
See application file for complete search history.

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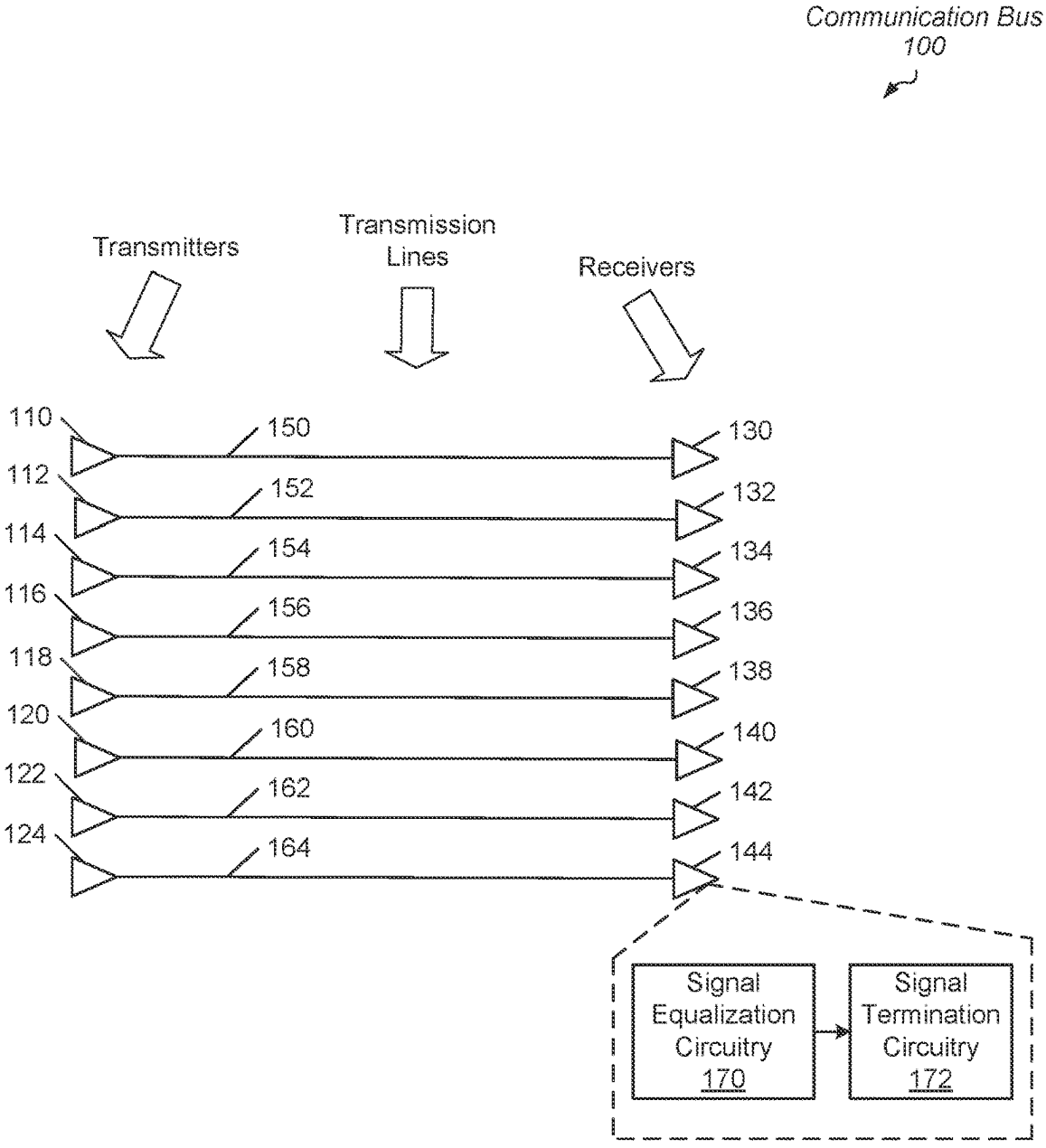
Communication Bus
100
Transmitters
Transmission Lines
Receivers
110
112
114
116
118
120
122
124
150
152
154
156
158
160
162
164
130
132
134
136
138
140
142
144
Signal Equalization Circuitry 170
Signal Termination Circuitry 172

FIG. 1

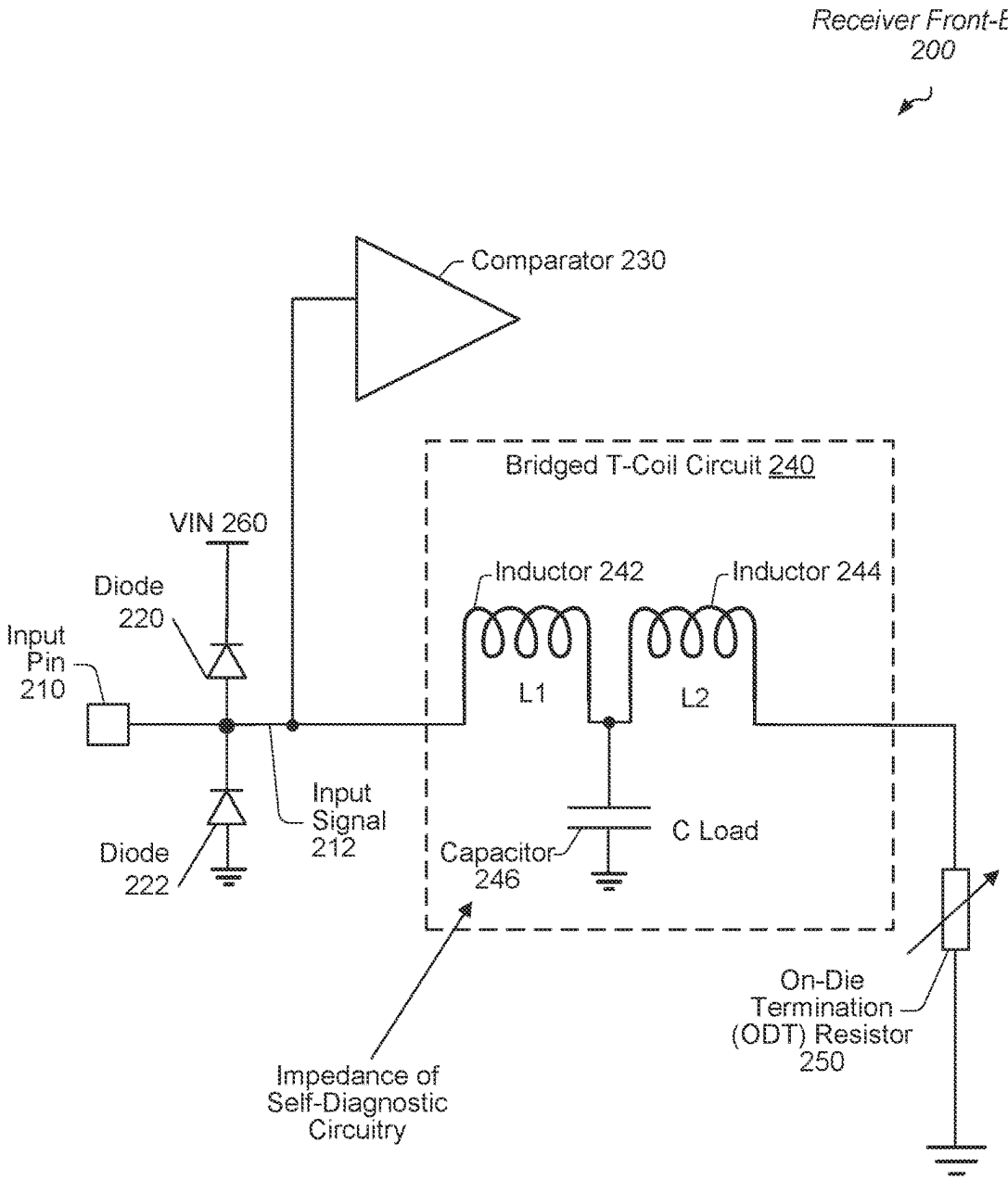
Receiver Front-End
200
Comparator 230
Bridged T-Coil Circuit 240
VIN 260
Diode
220
Inductor 242
Inductor 244
Input
Pin
210
L1
L2
Input
Signal
212
Diode
222
Capacitor
246
C Load
On-Die
Termination
(ODT) Resistor
250
Impedance of
Self-Diagnostic
Circuitry

FIG. 2

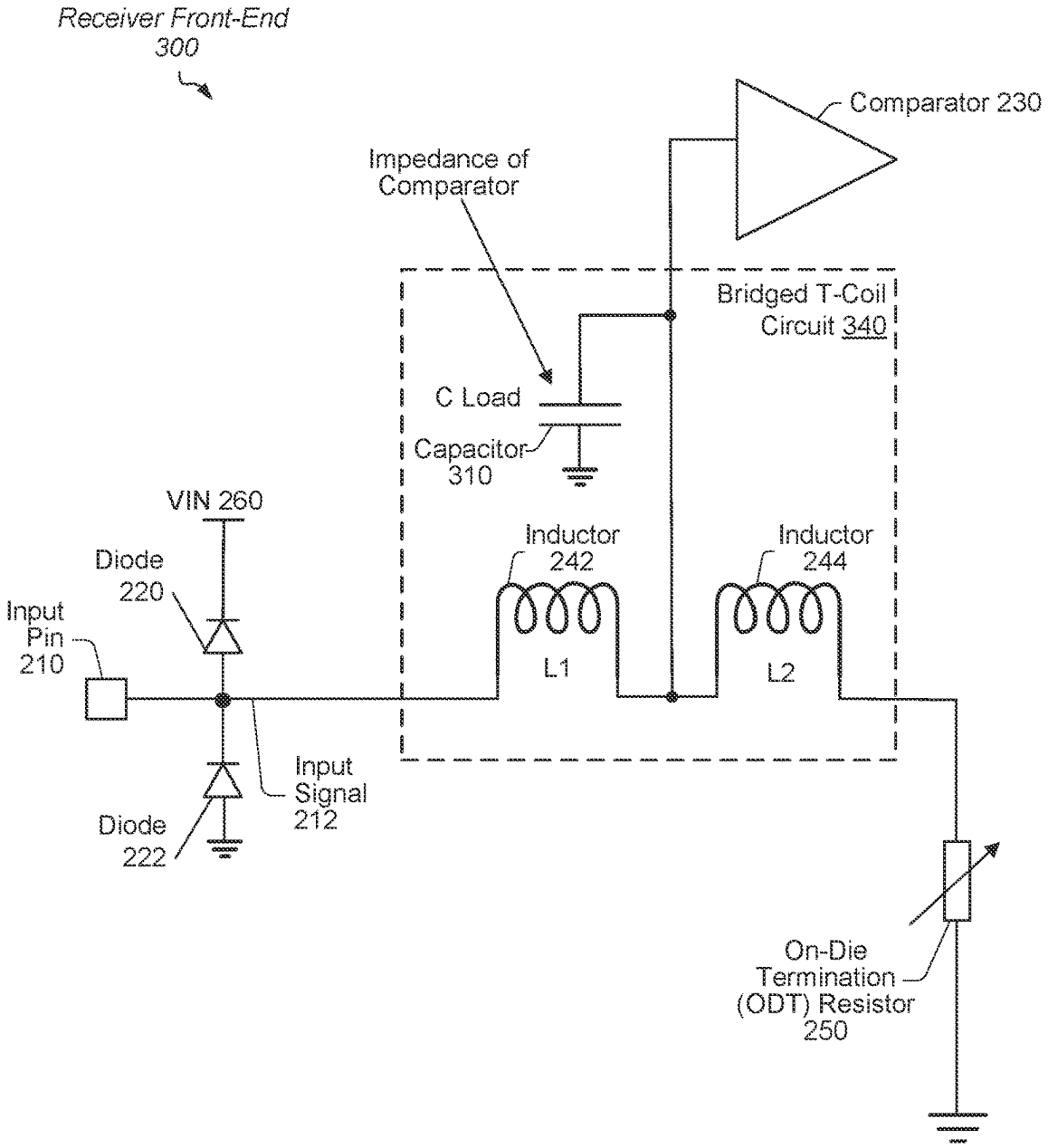
Receiver Front-End
300
Comparator 230
Impedance of
Comparator
Bridged T-Coil
Circuit 340
C Load
Capacitor
310
VIN 260
Diode
220
Inductor
242
Inductor
244
Input
Pin
210
L1
L2
Input
Signal
212
Diode
222
On-Die
Termination
(ODT) Resistor
250

FIG. 3

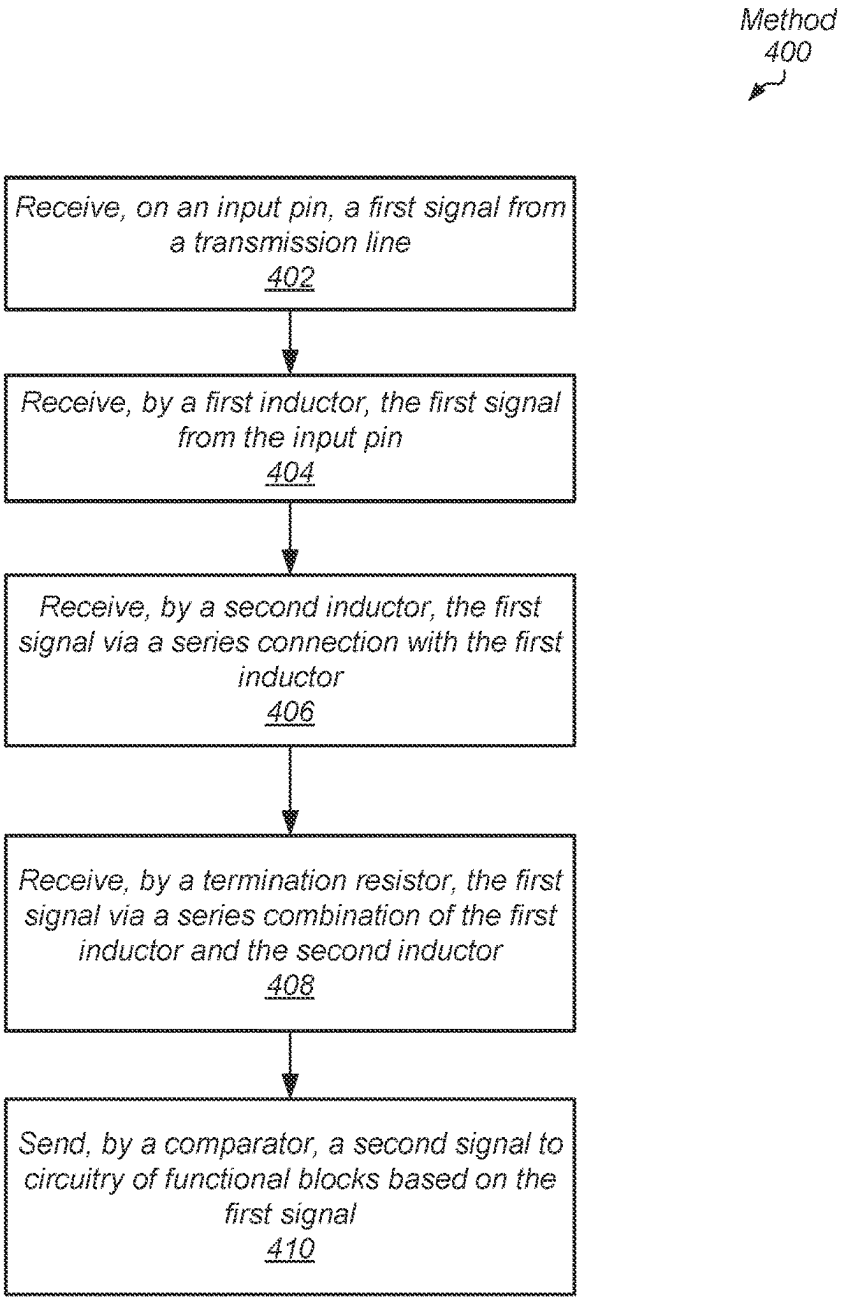
Method
400
Receive, on an input pin, a first signal from a transmission line
402
Receive, by a first inductor, the first signal from the input pin
404
Receive, by a second inductor, the first signal via a series connection with the first inductor
406
Receive, by a termination resistor, the first signal via a series combination of the first inductor and the second inductor
408
Send, by a comparator, a second signal to circuitry of functional blocks based on the first signal
410

FIG. 4

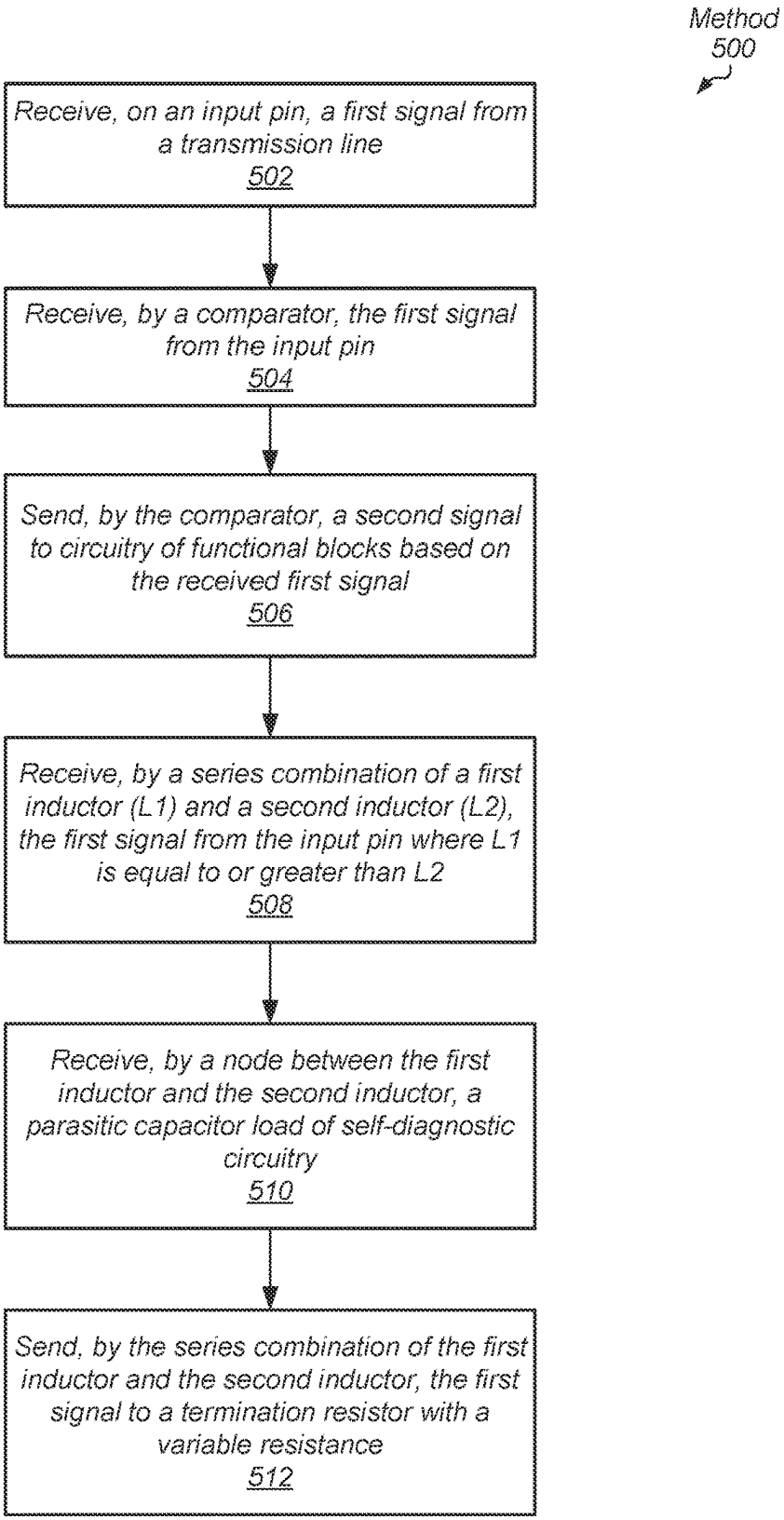
Method
500
Receive, on an input pin, a first signal from a transmission line
502
Receive, by a comparator, the first signal from the input pin
504
Send, by the comparator, a second signal to circuitry of functional blocks based on the received first signal
506
Receive, by a series combination of a first inductor (L1) and a second inductor (L2), the first signal from the input pin where L1 is equal to or greater than L2
508
Receive, by a node between the first inductor and the second inductor, a parasitic capacitor load of self-diagnostic circuitry
510
Send, by the series combination of the first inductor and the second inductor, the first signal to a termination resistor with a variable resistance
512

FIG. 5

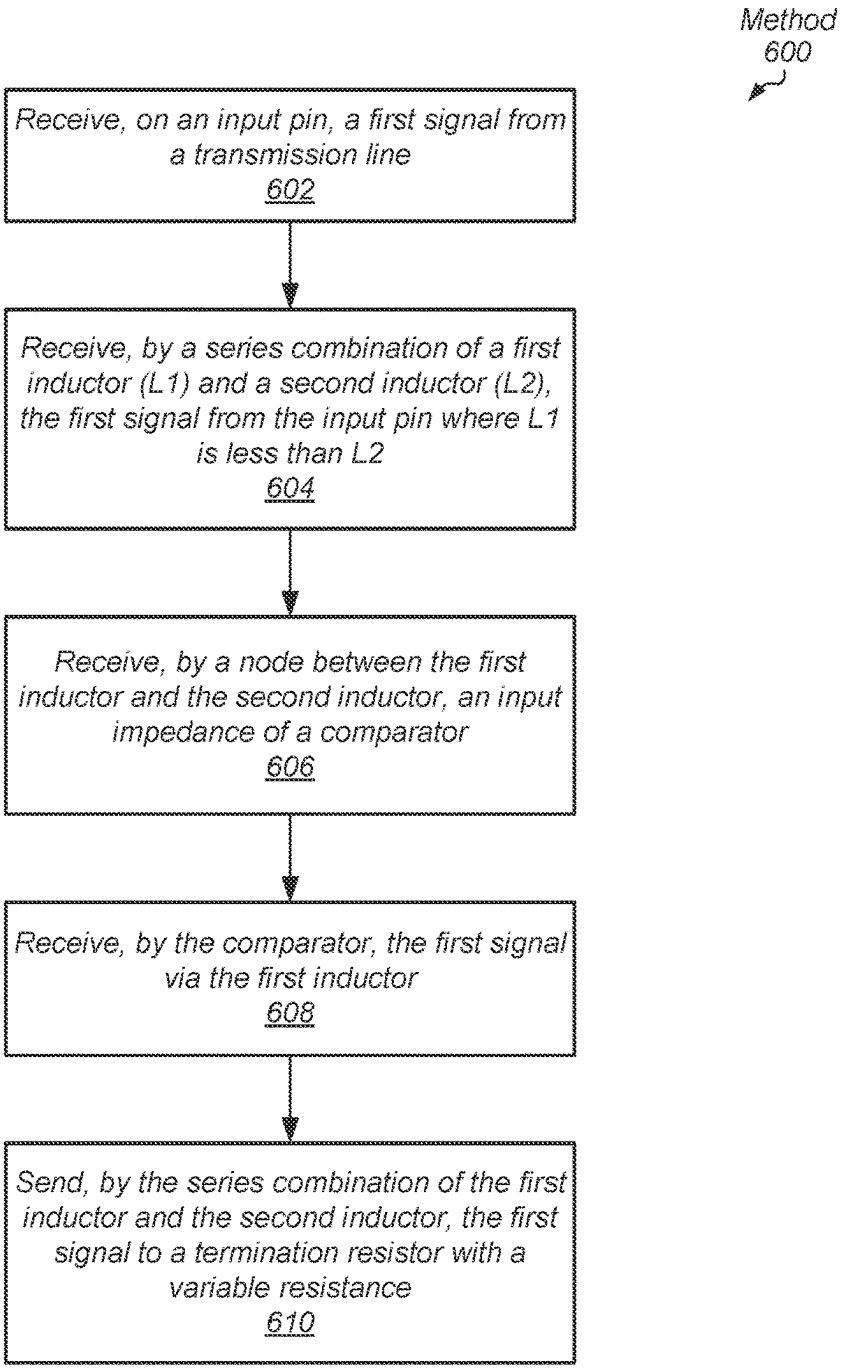
Method
600
Receive, on an input pin, a first signal from a transmission line
602
Receive, by a series combination of a first inductor (L1) and a second inductor (L2), the first signal from the input pin where L1 is less than L2
604
Receive, by a node between the first inductor and the second inductor, an input impedance of a comparator
606
Receive, by the comparator, the first signal via the first inductor
608
Send, by the series combination of the first inductor and the second inductor, the first signal to a termination resistor with a variable resistance
610

FIG. 6

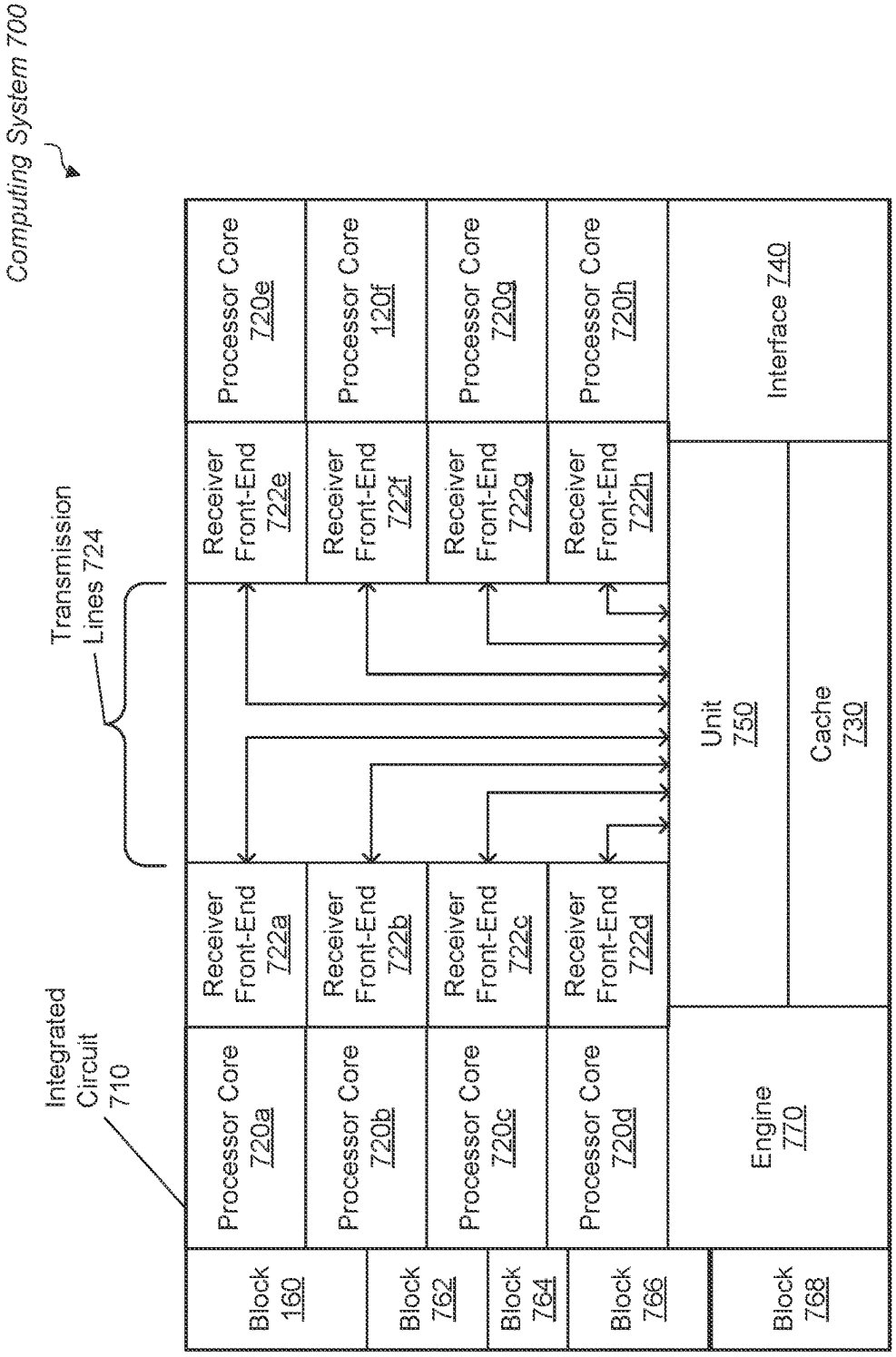
Computing System 700
Integrated Circuit 710
Transmission Lines 724
Block 160
Block 762
Block 764
Block 766
Block 768
Processor Core 720a
Processor Core 720b
Processor Core 720c
Processor Core 720d
Engine 770
Receiver Front-End 722a
Receiver Front-End 722b
Receiver Front-End 722c
Receiver Front-End 722d
Receiver Front-End 722e
Receiver Front-End 722f
Receiver Front-End 722g
Receiver Front-End 722h
Processor Core 720e
Processor Core 120f
Processor Core 720g
Processor Core 720h
Unit 750
Cache 730
Interface 740

FIG. 7

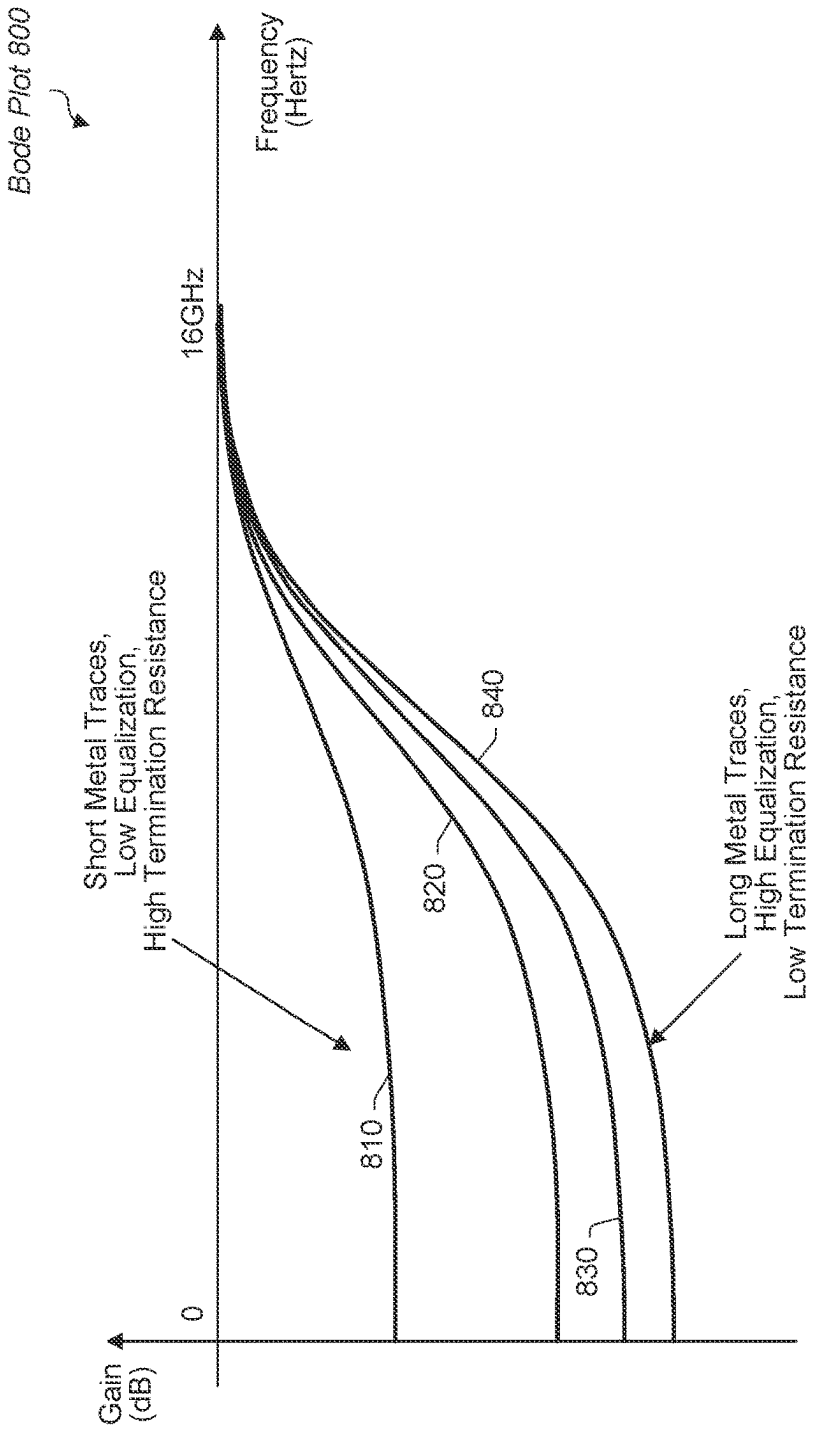
Bode Plot 800
Frequency (Hertz)
16GHz
Gain (dB)
0
Short Metal Traces, Low Equalization, High Termination Resistance
Long Metal Traces, High Equalization, Low Termination Resistance
810
820
830
840

FIG. 8

RECEIVER EQUALIZATION CIRCUITRY USING VARIABLE TERMINATION AND T-COIL

BACKGROUND

Description of the Relevant Art

When transferring information between functional blocks in a semiconductor chip, electrical signals are sent on multiple, parallel metal traces. Transmitters in a first functional block send the electrical signals across the parallel metal traces. Receivers in a second functional block receive the electrical signals. In some cases, the two functional blocks are within a same die. In other cases, the two functional blocks are on separate dies. In either case, the metal traces have transmission line effects such as distributed inductance, capacitance and resistance throughout its length. For modern integrated circuits, the interconnect capacitance reduces signal integrity and signal transfer rate more so than gate capacitance of semiconductor devices.

The interconnect capacitance per unit length includes both sidewall fringing capacitance and cross-coupling capacitance. For example, the electromagnetic fields for the metal traces conducting signals and the return current on the ground plane create electrical interference on neighboring metal traces and on adjacent devices. As the operating voltage continues to decrease to reduce power consumption, the signal swing used for Boolean logic decreases as well as the noise margin.

In view of the above, efficient methods for receiving information as signals in a computing system are desired.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. **1** is a block diagram of one implementation of a communication bus.

FIG. **2** is a block diagram of one implementation of a receiver front-end.

FIG. **3** is a block diagram of one implementation of a receiver front-end.

FIG. **4** is a flow diagram of one implementation of a method for receiving information as signals in a computing system.

FIG. **5** is a flow diagram of one implementation of a method for receiving information as signals in a computing system.

FIG. **6** is a flow diagram of one implementation of a method for receiving information as signals in a computing system.

FIG. **7** is a block diagram of one implementation of a computing system using a communication bus.

FIG. **8** is a block diagram of one implementation of a bode plot.

While the invention is susceptible to various modifications and alternative forms, specific implementations are shown by way of example in the drawings and are herein described in detail. It should be understood, however, that drawings and detailed description thereto are not intended to limit the invention to the particular form disclosed, but on the contrary, the invention is to cover all modifications, equivalents and alternatives falling within the scope of the present invention as defined by the appended claims.

DETAILED DESCRIPTION

In the following description, numerous specific details are set forth to provide a thorough understanding of the present invention. However, one having ordinary skill in the art should recognize that the invention might be practiced without these specific details. In some instances, well-known circuits, structures, and techniques have not been shown in detail to avoid obscuring the present invention. Further, it will be appreciated that for simplicity and clarity of illustration, elements shown in the figures have not necessarily been drawn to scale. For example, the dimensions of some of the elements are exaggerated relative to other elements.

Various systems, apparatuses, methods, and computer-readable mediums for receiving information as signals in a computing system are disclosed. In various implementations, a computing system includes one or more functional blocks for processing applications. Examples of the functional blocks include a general-purpose central processing unit (CPU), a graphics processing unit (GPU), an accelerated processing unit (APU), a variety of input/output (I/O) devices, a memory controller for system memory, and so forth. The computing system also includes multiple interfaces for transferring data between the functional blocks. In some cases, two functional blocks transferring data between one another are within a same die. In other cases, the two functional blocks are on separate dies.

When transferring information between functional blocks, electrical signals are sent on multiple, parallel metal traces. Transmitters in a first functional block send the electrical signals across the parallel metal traces. Receivers in a second functional block receive the electrical signals. The metal traces have transmission line effects, such as distributed inductance, capacitance and resistance throughout the line length. To reduce signal reflection, the far end (receiving end) of the metal traces is terminated using the characteristic impedances of the metal traces. In some implementations, on-die termination (ODT) is used where a termination resistor for impedance matching is located inside the receiver instead of externally from the receiver such as on a printed circuit board (PCB) or off-die on a system on a chip (SOC) or multichip module (MCM).

The transmission line effects of the metal traces cause the signals being transmitted to experience loss and distortion, especially at relatively high frequency. Therefore, in addition to terminating the metal trace at the receiver, each receiver includes circuitry for equalization. Circuitry that performs equalization corrects for these losses and distortions by further boosting, or amplifying, the higher frequency component of an input signal received at the receiver, which allows each of the frequency components of this input signal to have a similar amplitude. Thus, the circuitry that performs equalization increases the high frequency gain of the input signal. The transmission line effects of the metal traces provide low-pass characteristics on the signals being transmitted. Therefore, the circuitry that performs equalization by providing a linear high-pass filter that offsets the low-pass characteristics of the metal traces.

The circuitry that performs equalization (or the equalization circuitry) at the receiver uses passive elements with no active elements such as transistors. Therefore, the equalization circuitry provides low power consumption, and consumes a relatively small amount of on-die area. In various implementations, the equalization circuitry is a linear filter used at the receiver that attenuates low frequency signal components, and boosts or amplifies the higher frequency signal components such as signal components near or at the Nyquist frequency. In various implementations, the equalization circuitry provides continuous time linear equalization (CTLE) with no feedback loop. Therefore, the equal-

ization circuitry of the receivers does not use decision feedback equalization (DFE) with a decision circuit.

In various implementations, the equalization circuitry uses a bridged T-coil circuit between an input pin that receives the input signal and the termination resistor. The termination resistor has a variable resistance that is set based on reducing signal reflection on the transmission line. In other words, the termination resistor has its variable resistance set to provide impedance matching with the transmission line. The bridged T-coil circuit reduces the rise time of the voltage at the termination resistor by having the inductors of the bridged T-coil circuit temporarily disconnect the termination resistor from the capacitor. The current flowing through the inductors cannot change instantaneously, which allows the inductors to temporarily disconnect the termination resistor from the capacitor. Therefore, the inductors are able to direct the input current for a particular amount of time to only the capacitor of the bridged T-coil circuit. The capacitor charges more quickly than if the capacitor is directly connected in a parallel manner with the termination resistor.

Additionally, due to the presence of the inductors of the bridged T-coil circuit, the high frequency components of the input signal are not attenuated by the capacitor. The receiver also includes a comparator that receives the input signal and compares the input signal to a reference voltage. In an implementation, the comparator is a sense amplifier. The placement of the comparator and the ratio of the inductances of the inductors of the bridged T-coil circuit are based on whether the receiver includes self-diagnostic circuitry. Further details of the equalization circuitry are provided in the following discussion.

Referring to FIG. **1**, a generalized block diagram of one implementation of a communication bus **100** is shown. As shown, communication bus **100** includes transmitters **110-124** for sending information as electrical signals, transmission lines **150-164** for transferring the electrical signals, and receivers **130-144** for receiving the signals. In various implementations, one or more of the receivers **130-144** include signal equalization circuitry **170** and signal termination circuitry **172**. The directions of the transmitter currents on transmission lines **150-164** are based on whether the transmission lines **150-164** are being charged to logic high values or discharged to logic low values. In other words, the direct current (DC) patterns on the transmission lines **150-164** vary over time.

It is noted that the term "bus" may also be referred to as a "channel," and each "transmission line" is a "lane" or a "trace" or a "wire." In various implementations, transmission lines **150-164** are constructed from a variety of suitable metal sources during semiconductor fabrication and surrounded by a variety of any suitable insulating material. It is also noted that the terms "pin," "port," "terminal," and "node" are used interchangeably herein. Although eight transmitters **110-124**, eight transmission lines **150-164** and eight receivers **130-144** are shown, in other implementations, any number of these components is used.

In some implementations, the signals sent from transmitters **110-124** to receivers **130-144** are single-ended data signals. The term "single-ended signal" is defined as an electric signal which is transmitted using a single signal conductor. For example, in an implementation, receiver **130** receives a single-ended signal from transmitter **110** via transmission line **150**, which is a single signal conductor. In contrast to using single-ended data signals, sending information with differential data signals uses more lines and more pins. A reference signal is not used by the receivers **130-144** when differential data signals are used. As is known in the art, differential signaling generally provides better noise immunity than single-ended signaling. However, the use of differential signaling comes at the added cost of extra pins and extra traces.

In order to better handle noise issues when using single-ended signaling, one or more of the receivers **130-144** of the communication bus **100** include signal equalization circuitry **170** and signal termination circuitry **172**. The signal termination circuitry **172** prevents reflection on a corresponding transmission line ending at a corresponding receiver. As shown, the signal termination circuitry **172** prevents reflection on transmission line **164** that includes reflection at any impedance change point between the transmitter **124** and the receiver **144**. Although only receiver **144** is shown to include the signal equalization circuitry **170** and signal termination circuitry **172**, it is possible and contemplated that one or more of the receivers **130-142** also include this type of circuitry. In an implementation, the signal termination circuitry **172** includes an on-die termination (ODT) resistor with a variable resistance capable of being set at two or more predetermined resistance values.

In various implementations, the signal equalization circuitry **170** uses a bridged T-coil circuit to provide continuous time linear equalization (CTLE) with no feedback loop. The signal equalization circuitry **170** performs equalization by providing a high-pass filter that offsets the low-pass characteristics of the transmission line **164**. Although not shown, the receiver **144** also includes a comparator that receives the input signal and compares the input signal to a reference voltage. In an implementation, the comparator is a sense amplifier. The placement of the comparator and the ratio of the inductances of the inductors of the bridged T-coil circuit in the signal equalization circuitry **170** are based on whether the receiver **144** includes self-diagnostic circuitry.

Turning now to FIG. **2**, a generalized block diagram of one implementation of a receiver front-end **200** is shown. In the illustrated implementation, receiver front-end **200** includes an input pin **210** for receiving an input signal **212**, diodes **220** and **222** that provide electrostatic discharge (ESD) protection, and a comparator **230** that sends an output signal based on the input signal **212** to a functional block (not shown) that includes at least a data storage element and a deserializer. The receiver front-end **200** also includes the on-die termination (ODT) resistor **250** and the bridged T-coil circuit **240** that provides equalization for the input signal **212**.

The ESD protection circuitry uses clamping circuits such as diodes **220** and **222** in a series configuration. When an input voltage received on input pin **210** exceeds a supply voltage VIN **260** by a diode drop, the diode **220** turns on and conducts. Therefore, the voltage on the node of the input pin **210**, which is also between the serially connected diodes **220** and **222**, is clamped to the supply voltage VIN **260**. When the input voltage received on input pin **210** falls below the ground reference voltage by the diode drop, the diode **222** turns on and conducts. Therefore, the voltage on the node of the input pin **210**, which is also between the serially connected diodes **220** and **222**, is clamped to the ground reference voltage. The range of voltages on the input pin **210** does not exceed the supply voltage VIN **260** by more than a threshold and does not fall below the ground reference voltage by more than a threshold. Here, the threshold is the diode drop of the diodes **220** and **222**.

The ODT resistor **250** prevents reflection on a corresponding transmission line ending at input pin **210**. Reflection at any impedance change point on the external trans-

mission line including the end of the transmission line at receiver front-end **200** results in signal distortion, signal ringing and so forth. In some implementations, the ODT resistor **250** is a variable resistance capable of being set at two or more predetermined values. As shown, the ODT resistor **250** receives input signal **212** via inductors **242** and **244**.

The comparator **230** receives the input signal **212** from the input pin **210**, compares the received input signal to another signal, and generates an output signal based on the comparison. The comparator **230** sends the output signal to other circuitry, which is not shown for ease of illustration. In an implementation, the comparator **230** is implemented as a sense amplifier. In some implementations, the comparator **230** is a clocked sense amplifier although a clock input signal is not shown. In some implementations, the comparator **230** receives the input signal **212** on a positive terminal and receives a termination voltage on a negative terminal.

In an implementation, a period of time between a rising edge and a falling edge on the input signal **212** is used to determine a number of logic high values (binary '1') in an input bit stream. A period of time between a falling edge and a rising edge on the input signal **212** is used to determine a number of logic low values (binary '0') in the input bit stream. In an implementation, the comparator **230** sends a stream of binary values to a deserializer (not shown), which is included in the receiver outside of the front-end **200**. In an implementation, the deserializer generates a sequence of parallel data words from the received stream of binary values and sends the data words to other logic blocks and/or arithmetic logic units. In some implementations, the deserializer decreases the data transfer rate, which allows the other logic blocks to operate at a lower clock frequency than clocked sense amplifiers.

The combination of the inductors L1 **242** and L2 **244** and the capacitor C Load **246** provides the bridged T-coil circuit **240**. The bridged T-coil circuit **240** reduces the rise time of the voltage at the ODT resistor **250** by having the inductor L2 **244** temporarily disconnect the ODT resistor **250** from the capacitor C Load **246**. The current flowing through the inductors L1 **242** and L2 **244** cannot change instantaneously, which allows the inductors L1 **242** and L2 **244** to temporarily disconnect the ODT resistor **250** from the capacitor C Load **246**. Therefore, the inductors L1 **242** and L2 **244** are able to direct the input signal **212** for a particular amount of time to only the capacitor C Load **246** of the bridged T-coil circuit **240**. The capacitor C Load **246** charges more quickly than if the capacitor C Load **246** is directly connected in a parallel manner with the ODT resistor **250**.

Additionally, due to the presence of the inductors L1 **242** and L2 **244** of the bridged T-coil circuit **240**, the high frequency components of the input signal **212** are not attenuated by the capacitor C Load **246**. The input impedance of the bridged T-coil circuit **240** is the ODT resistor **250**, and the impedance of the capacitor C Load **246** is hidden while the impedances of the inductors L1 **242** and L2 **244** are transparent. Therefore, the bridged T-coil circuit **240** is used as an impedance matching network to create a constant, resistive input impedance such as the value of the ODT resistor **250**. Further, the bridged T-coil circuit **240** provides equalization. As described earlier, circuitry that performs equalization corrects for losses and distortions of the input signal **212** caused by the low-pass characteristics of metal traces. The equalization circuitry, such as the bridged T-coil circuit **240**, provides a linear high-pass filter that amplifies the higher frequency component of the input signal **212**, which allows each of the frequency components of the input signal **212** to have a similar amplitude. The series combination of the inductors L1 **242** and L2 **244** provides equalization. Therefore, the bridged T-coil circuit **240** provides continuous time linear equalization (CTLE) with no feedback loop. For example, the bridged T-coil circuit **240** does not use decision feedback equalization (DFE).

As the inductances of the inductors L1 **242** and L2 **244** increases, the more equalization is provided by the bridged T-coil circuit **240**. However, as the inductances of the inductors L1 **242** and L2 **244** increases, the equivalent series resistance (ESR) of the inductors L1 **242** and L2 **244** also increase. Therefore, sizing the inductors L1 **242** and L2 **244** includes design tradeoffs. In various implementations, the inductances of the inductors L1 **242** and L2 **244** are the same, so the bridged T-coil circuit **240** is a symmetric bridged T-coil circuit. In these cases, the ratio of the inductance of inductor L1 **242** to the inductance of inductor L2 **244** is one. In other words, L1/L2=1. In other implementations, the inductance of inductor L1 **242** is slightly larger than the inductance of inductor L2 **244**. In these cases, the ratio of the inductance of inductor L1 **242** to the inductance of inductor L2 **244** is greater than one. In other words, L1>L2. How much L1 is greater than L2 is based on design requirements.

In various implementations, the receiver front-end **200** includes self-diagnostic circuitry (not shown). The self-diagnostic circuitry increases the reliability of the receiver that uses the receiver front-end **200**. Probing certain circuits, such as radio frequency (RF) integrated circuits (ICs) affects the behavior of these circuits. Additionally, the limited on-die area does not provide area for a significant number of test nodes that can be accessed. Therefore, a built-in self-test (BIST) approach is used to determine whether semiconductor fabrication process variations and process faults have rendered the receiver unsuitable for its intended purpose. The fault coverage provided by the BIST approach using the self-diagnostic circuitry is based on the selected design for test (DFT) strategy.

When the receiver front-end **200** includes self-diagnostic circuitry, this circuitry is connected to the node between the inductors L1 **242** and L2 **244**, and the capacitor C Load **246** models the impedance of this self-diagnostic circuitry. The self-diagnostic circuitry typically includes multiple components such as one or more of a test pattern generator, a BIST controller, selection logic that receives the signal on the node between the inductors L1 **242** and L2 **244**, a comparator, a counter, and so forth. The number and type of components used in the self-diagnostic circuitry is based on design requirements. Regarding the capacitor C Load **246**, the input of the selection logic is typically the component of the self-diagnostic circuitry that is directly connected to the node between the inductors L1 **242** and L2 **244**, and accordingly, provides the capacitance of the capacitor C Load **246**.

The selection logic typically includes a multiplexer, which can be implemented with Boolean logic gates, Boolean complex gates, or pass gates implemented with a pair of transistors. It is also possible and contemplated that an inverter or a buffer (two serially connected inverters) are used between the selection logic and the node between the inductors L1 **242** and L2 **244**. In such implementations, the input of the inverter that is directly connected to this node provides the capacitance of the capacitor C Load **246**. When pass gates are used for the selection logic, the diffusion capacitance of the source/drain terminals of the corresponding transistors provide the capacitance of the capacitor C Load **246**. When transistors implementing Boolean logic are

used for the selection logic, the gate capacitance of the gate terminals of the corresponding transistors provide the capacitance of the capacitor C Load **246**. Although not shown, in some implementations, the receiver front-end **200** includes additional ESD protection circuitry directly connected to the node between the inductors L1 **242** and L2 **244**. The capacitance of the corresponding two additional diodes connected in a series configuration on this node also contributes to the capacitance of the capacitor C Load **246**.

The inductances of the inductors L1 **242** and L2 **244** increase due to the relatively large impedance of the self-diagnostic circuitry (the capacitor C Load **246**). The increased inductances of the inductors L1 **242** and L2 **244** also increases the equalization provided by the bridged T-coil circuit **240**. However, increased inductances of the inductors L1 **242** and L2 **244** also increases the ESR of the inductors L1 **242** and L2 **244**. Therefore, the comparator **230** is connected to the node between the input pin **210** and the inductor L1 **242**, rather than connected to the node between the inductors L1 **242** and L2 **244** similar to the capacitor C Load **246**. The relatively large ESR of the inductor L1 **242** would distort the signal received by the comparator **230**. However, when receiver front-end **200** does not include self-diagnostic circuitry, it is possible for the comparator **230** to be moved and connected to the node between the inductors L1 **242** and L2 **244**. Such an implementation is described in the following discussion.

Turning now to FIG. **3**, a generalized block diagram of one implementation of a receiver front-end **300** is shown. Circuitry and signals previously described are numbered identically. The receiver front-end **300** includes the bridged T-coil circuit **340** that provides equalization for the input signal **212**. The bridged T-coil circuit **340** uses the inductors L1 **242** and L2 **244** and the capacitor C Load **310**. The receiver front-end **300** does not include self-diagnostic circuitry, so this circuitry is not connected to the node between the inductors L1 **242** and L2 **244**. The inductances of the inductors L1 **242** and L2 **244** decrease due to having no relatively large impedance of the self-diagnostic circuitry being connected between them. The decreased inductances of the inductors L1 **242** and L2 **244** also decreases the ESR of the inductors L1 **242** and L2 **244**. Therefore, the comparator **230** is connected to the node between the inductors L1 **242** and L2 **244**, rather than connected at the node between the input pin **210** and the inductor L1 **242**.

In the receiver front-end **300**, the comparator **230** receives the input signal **212** via the inductor L1 **242**. The relatively small ESR of the inductor L1 **242** in the receiver front-end **300** does not distort the signal received by the comparator **230**. The capacitor C Load **310** of the bridged T-coil circuit **340** models the input impedance of the comparator **230**. Referring briefly again to the receiver front end **200** (of FIG. **2**), the capacitor C Load **310**, which models the input impedance of the comparator **230**, is located at the node between the input pin **210** and the inductor L1 **242**.

Referring now to FIG. **4**, one implementation of a method **400** for receiving information as signals in a computing system is shown. For purposes of discussion, the steps in this implementation (as well as in FIGS. **5-6**) are shown in sequential order. However, it is noted that in various implementations of the described methods, one or more of the elements described are performed concurrently, in a different order than shown, or are omitted entirely. Other additional elements are also performed as desired. Any of the various systems or apparatuses described herein are configured to implement method **400**.

An input pin of a receiver front-end receives a first signal from a transmission line (block **402**). In some implementations, the first signal is a single-ended data signal. In an implementation, a transmitter sends the first signal across a transmission line to a receiver that includes the receiver front-end. A first inductor receivers the first signal from the input pin (block **404**). The receiver front-end uses a bridged T-coil circuit to provide equalization. The first inductor is one of two inductors of the bridged T-coil circuit. A second inductor receives the first signal via a series connection with the first inductor (block **406**). A termination resistor, such as an ODT resistor, receives the first signal via the series combination of the first inductor and the second inductor (block **408**). The series combination of the first inductor and the second inductor provides an input impedance of the receiver front-end equal to the termination resistor. A comparator sends a second signal to circuitry of functional blocks based on the first signal (block **410**). In some implementations, the comparator is a sense amplifier, such as a clocked sense amplifier, that compares the first signal to a reference voltage. The comparator generates the second signal based on the comparison.

Turning now to FIG. **5**, one implementation of a method **500** for receiving information as signals in a computing system is shown. An input pin of a receiver front-end receives a first signal from a transmission line (block **502**). In some implementations, the first signal is a single-ended data signal. In an implementation, a transmitter sends the first signal across a transmission line to a receiver that includes the receiver front-end. The receiver front-end uses a bridged T-coil circuit to provide equalization. The first inductor is one of two inductors of the bridged T-coil circuit. A comparator receives the first signal from the input pin (block **504**). The comparator sends a second signal to circuitry of functional blocks based on the received first signal (block **506**).

A series combination of a first inductor and a second inductor of the bridged T-coil circuit receives the first signal from the input pin (block **508**). A first inductance (L1) of the first inductor is equal to or greater than a second inductance (L2) of the second inductor. In other words, L1>L2, or the ratio of L1 to L2 is equal to or greater than one. A node between the first inductor and the second inductor receives a parasitic capacitor load of self-diagnostic circuitry (block **510**). Therefore, the inductances of the first inductor and the second inductor are relatively large. Accordingly, the comparator is connected as described externally from the bridged T-coil circuit. The series combination of the first inductor and the second inductor sends the first signal to a termination resistor with a variable resistance (block **512**). In some implementations, the termination resistor is statically set once to a predetermined value based on the impedance of the transmission line. In another implementation, the termination resistor is initially set to a predetermined value based on the impedance of the transmission line, and then dynamically updated based on operating conditions that change the impedance of the transmission line. For example, operating temperature and circuit age affect the impedance of the transmission line. The receiver front-end includes a state machine or other control circuitry that dynamically updates the resistance of the termination resistor.

Referring to FIG. **6**, one implementation of a method **600** for receiving information as signals in a computing system is shown. An input pin of a receiver front-end receives a first signal from a transmission line (block **602**). In some implementations, the first signal is a single-ended data signal. In an implementation, a transmitter sends the first signal across

a transmission line to a receiver that includes the receiver front-end. The receiver front-end uses a bridged T-coil circuit to provide equalization. A series combination of a first inductor (L1) and a second inductor (L2) of the bridged T-coil circuit receives the first signal from the input pin (block **604**). A first inductance (L1) of the first inductor is less than a second inductance (L2) of the second inductor. In other words, L1<L2, or the ratio of L1 to L2 is less than one.

A node between the first inductor and the second inductor receives an input impedance of a comparator (block **606**). The comparator receives the first signal via the first inductor (block **608**). When the receiver front-end does not include self-diagnostic circuitry, the inductances of the first inductor and the second inductor decrease. The decreased inductances reduce the equalization provided by the bridged T-coil circuit, but allow the comparator to be placed at the node between the first inductor and the second inductor. Therefore, the signal received by the comparator has some loss and distortion removed by the equalization provided by the bridged T-coil circuit. The series combination of the first inductor and the second inductor sends the first signal to a termination resistor with a variable resistance (block **610**). The equalization provided by the bridged T-coil circuit causes the input impedance of the receiver front-end to be the resistance of the termination resistor.

Turning now to FIG. **7**, a generalized block diagram of one implementation of a computing system **700** using a communication bus is shown. The integrated circuit **710** includes processor cores **720***a*-**720***h*, cache **730**, interface **740**, unit **750**, functional blocks **760**-**768**, and engine **770**. The processor cores **720***a*-**720***h* use receiver front-end blocks **722***a*-**722***h* for communicating with unit **750**. The integrated circuit **710** includes multiple types of designs providing a variety of functionalities. In some implementations, the integrated computing system **700** is a system on a chip (SoC) that includes a variety of processing units and functional blocks providing a variety of functionalities. In an implementation, cache **730**, interface **740**, unit **750**, functional blocks **760**-**768**, and engine **770** provide separate functionality. In contrast, each of processor cores **720***a*-**720***h* provides a same functionality. For example, in some designs, each of processor cores **720***a*-**720***h* is an instantiation of a same processor core. It is also possible and contemplated that two or more of the functional blocks **760**-**768** provide a same functionality.

In some implementations, the integrated circuit **710** includes a central processing unit (CPU) with circuitry used for processing instructions of a selected instruction set architecture (ISA), a graphics processing unit (GPU) with circuitry that implements a high parallel data microarchitecture, a Hub used for communicating with multimedia engine, and a multimedia engine, such as engine **770**, with circuitry that processes audio data and visual data for multimedia applications. In another implementation, the unit **750** and the functional blocks **760**-**768** include one or more application specific integrated circuits (ASICs) or microcontrollers, one or more digital signal processors (DSPs), analog-to-digital converters (ADCs), and digital-to-analog converters (DACs).

In an implementation, a communication fabric supports communication between the components of the integrated circuit **710**. The communication fabric supports the transfer of messages, requests, responses, acknowledgments, commands, interrupts, and so forth between the multiple components within the integrated circuit **710** and one or more external processing units and peripheral devices. In various implementations, the communication among components of the integrated circuit **710** includes at least the transmission lines **724** between the unit **750** and the processor cores **720***a*-**720***h*, each using a corresponding one of the receiver front-end blocks **722***a*-**722***h*. In various implementations, each of the receiver front-end blocks **722***a*-**722***h* utilizes an implementation such as the receiver front-end **200** (of FIG. **2**) and the receiver front-end **300** (of FIG. **3**) based on whether the receiver front-end blocks **722***a*-**722***h* includes self-diagnostic circuitry.

As shown, the transmission lines **724** have varying metal trace lengths based on an on-die location of a corresponding one of the processor cores **720***a*-**720***h*. Therefore, the impedance of the transmission lines **724** vary among one another. In addition to the varying metal trace lengths, in some implementations, the metal traces of the transmission lines **724** also vary among metal layer thicknesses and spacings between metal traces. Each of the receiver front-end blocks **722***a*-**722***h* include a termination resistor with a variable resistance set based on an impedance of a corresponding one of the transmission lines **724**. In some implementations, the termination resistor is statically set once to a predetermined value based on the impedance of a corresponding one of the transmission lines **724**. In another implementation, the termination resistor is initially set to a predetermined value based on the impedance of a corresponding one of the transmission lines **724**, and then dynamically updated based on operating conditions that change the impedance of the corresponding one of the transmission lines **724**. For example, operating temperature and circuit age affect the impedance of the corresponding one of the transmission lines **724**. The receiver front-end blocks **722***a*-**722***h* include a state machine or other control circuitry that dynamically updates the resistance of the termination resistor.

The circuitry of the interface **740** communicates with one of an external memory, an external peripheral device, another semiconductor chip, or other. The interface **740** includes queues for storing requests and responses as well as circuitry for supporting a particular communication protocol. Although a single interface is shown, it is possible and contemplated that the integrated circuit **710** uses multiple interfaces. In various implementations, the multiple components of the integrated circuit **710** supports a cache memory subsystem that includes integrated caches as well as external caches such as the shared cache **730**.

Referring to FIG. **8**, a generalized block diagram of one implementation of a Bode plot **800** is shown. The waveforms **810**-**840** illustrate gain versus frequency of different receiver front-end blocks. The y-axis of the Bode plot **800** is the gain, or a ratio of the output voltage to the input voltage, measured in dB, and since dB is logarithmic measurement, the gain is plotted on a logarithmic (log) scale. The x-axis of the Bode plot **800** is frequency of the input signal being transmitted on a transmission line. The frequency is also measured on a logarithmic scale, so the Bode plot **800** is a log-log plot. For relatively short transmission lines, the corresponding receiver front-end block provides less equalization, but a higher termination resistance. The waveform **810** illustrates these characteristics. Therefore, the receiver front-end block corresponding to waveform **810** has the smallest amount of inductances for the series combination of inductors of the bridged T-coil circuit among the receiver front-end blocks that provide the waveforms **810**-**840**.

In contrast, for relatively long transmission lines, the corresponding receiver front-end block provides more equalization, but a lower termination resistance. The waveform **840** illustrates these characteristics. Therefore, the receiver front-end block corresponding to waveform **840** has

the largest amount of inductances for the series combination of inductors of the bridged T-coil circuit among the receiver front-end blocks that provide the waveforms **810-840**. The waveforms **820** and **830** illustrate intermediate characteristics between the waveforms **810** and **840**. The amount of inductance for the series combination of inductors of the bridged T-coil circuits are also based on whether the receiver front-end blocks include self-diagnostic circuitry. For example, in various implementations, the receiver front-end blocks utilize one of the receiver front-end **200** (of FIG. **2**) and the receiver front-end **300** (of FIG. **3**).

It is noted that one or more of the above-described implementations include software. In such implementations, the program instructions that implement the methods and/or mechanisms are conveyed or stored on a computer readable medium. Numerous types of media which are configured to store program instructions are available and include hard disks, floppy disks, CD-ROM, DVD, flash memory, Programmable ROMs (PROM), random access memory (RAM), and various other forms of volatile or non-volatile storage. Generally speaking, a computer accessible storage medium includes any storage media accessible by a computer during use to provide instructions and/or data to the computer. For example, a computer accessible storage medium includes storage media such as magnetic or optical media, e.g., disk (fixed or removable), tape, CD-ROM, or DVD-ROM, CD-R, CD-RW, DVD-R, DVD-RW, or Blu-Ray. Storage media further includes volatile or non-volatile memory media such as RAM (e.g. synchronous dynamic RAM (SDRAM), double data rate (DDR, DDR2, DDR3, etc.) SDRAM, low-power DDR (LPDDR2, etc.) SDRAM, Rambus DRAM (RDRAM), static RAM (SRAM), etc.), ROM, Flash memory, non-volatile memory (e.g. Flash memory) accessible via a peripheral interface such as the Universal Serial Bus (USB) interface, etc. Storage media includes microelectromechanical systems (MEMS), as well as storage media accessible via a communication medium such as a network and/or a wireless link.

Additionally, in various implementations, program instructions include behavioral-level descriptions or register-transfer level (RTL) descriptions of the hardware functionality in a high level programming language such as C, or a design language (HDL) such as Verilog, VHDL, or database format such as GDS II stream format (GDSII). In some cases the description is read by a synthesis tool, which synthesizes the description to produce a netlist including a list of gates from a synthesis library. The netlist includes a set of gates, which also represent the functionality of the hardware including the system. The netlist is then placed and routed to produce a data set describing geometric shapes to be applied to masks. The masks are then used in various semiconductor fabrication steps to produce a semiconductor circuit or circuits corresponding to the system. Alternatively, the instructions on the computer accessible storage medium are the netlist (with or without the synthesis library) or the data set, as desired. Additionally, the instructions are utilized for purposes of emulation by a hardware based type emulator from such vendors as Cadence®, EVE®, and Mentor Graphics®.

Although the implementations above have been described in considerable detail, numerous variations and modifications will become apparent to those skilled in the art once the above disclosure is fully appreciated. It is intended that the following claims be interpreted to embrace all such variations and modifications.

What is claimed is:

1. A circuit comprising:

an input configured to receive a first signal from a transmission line comprising a metal trace with an impedance along the metal trace;

a first inductor coupled to receive the first signal from the input;

a second inductor connected in series with the first inductor, wherein a node between the first inductor and the second inductor comprises a capacitive load of circuitry that processes the first signal and at least one other signal within the circuit;

a termination resistor connected in series with the second inductor; and

a comparator configured to convey a second signal based on the first signal to circuitry of functional blocks.

2. The circuit as recited in claim **1**, further comprising electrostatic discharge (ESD) protection circuitry between the input and the first inductor, wherein the ESD protection circuitry is configured to clamp the first signal to a given range of voltages.

3. The circuit as recited in claim **1**, wherein the capacitive load of circuitry comprises a parasitic capacitive load of self-diagnostic circuitry.

4. The circuit as recited in claim **3**, wherein the termination resistor has a resistance that provides an impedance matching the impedance of the metal trace of the transmission line.

5. The circuit as recited in claim **3**, wherein a first inductance of the first inductor is equal to or greater than a second inductance of the second inductor.

6. The circuit as recited in claim **1**, wherein:

the comparator is configured to receive the first signal via the first inductor; and

the capacitive load of circuitry comprises an input capacitance of the comparator.

7. The circuit as recited in claim **6**, wherein a first inductance of the first inductor is less than a second inductance of the second inductor.

8. A method comprising:

receiving, by an input, a first signal from a transmission line comprising a metal trace with an impedance along the metal trace;

receiving, by a first inductor, the first signal from the input;

receiving, by a second inductor, the first signal via a series connection with the first inductor, wherein a node between the first inductor and the second inductor comprises a capacitive load of circuitry that processes the first signal and at least one other signal within a receiver that comprises the first inductor and the second inductor;

receiving, by a termination resistor, the first signal via a series connection with a series combination of the first inductor and the second inductor; and

conveying, by a comparator, a second signal based on the first signal to circuitry of functional blocks.

9. The method as recited in claim **8**, further comprising clamping the first signal to a given range of voltages by electrostatic discharge (ESD) protection circuitry between the input and the first inductor.

10. The method as recited in claim **8**, wherein the capacitive load of circuitry comprises a parasitic capacitive load of self-diagnostic circuitry.

11. The method as recited in claim 10, wherein the termination resistor has a resistance that provides an impedance matching the impedance of the metal trace of the transmission line.

12. The method as recited in claim 10, wherein a first inductance of the first inductor is equal to or greater than a second inductance of the second inductor.

13. The method as recited in claim 8, further comprising receiving, by the comparator, the first signal via the first inductor, wherein the capacitive load of circuitry comprises an input capacitance of the comparator.

14. The method as recited in claim 13, wherein a first inductance of the first inductor is less than a second inductance of the second inductor.

15. An apparatus comprising:

a plurality of receivers configured to receive signals; and

a plurality of transmitters configured to send a plurality of signals to the plurality of receivers via a plurality of transmission lines, each comprising a metal trace with a corresponding impedance along the metal trace;

wherein a given receiver of the plurality of receivers is configured to receive a first signal of the plurality of signals from a given transmitter of the plurality of transmitters; and

wherein the given receiver comprises:

an input configured to receive the first signal from the given transmitter via a transmission line of the plurality of transmission lines;

a first inductor coupled to receive the first signal from the input;

a second inductor connected in series with the first inductor, wherein a node between the first inductor and the second inductor comprises a capacitive load of circuitry of the given receiver that processes the first signal and at least one other signal within the given receiver;

a termination resistor connected in series with the second inductor; and

a comparator configured to convey a second signal based on the first signal to circuitry of functional blocks.

16. The apparatus as recited in claim 15, wherein the capacitive load of circuitry comprises a parasitic capacitive load of self-diagnostic circuitry.

17. The apparatus as recited in claim 16, wherein the termination resistor has a resistance that provides an impedance matching the impedance of the metal trace of the transmission line.

18. The apparatus as recited in claim 16, wherein a first inductance of the first inductor is equal to or greater than a second inductance of the second inductor.

19. The apparatus as recited in claim 15, wherein:

the comparator is configured to receive the first signal via the first inductor; and

the capacitive load of circuitry comprises an input capacitance of the comparator.

20. The apparatus as recited in claim 19, wherein a first inductance of the first inductor is less than a second inductance of the second inductor.

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